

Search Notes

Application/Control No.

10/732,720

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination

KWON ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	104,253, 254,257, 261,288, 293	2/8/2005	NKV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
CLASSES	ABOVE	6/30/2005	NKV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	6/30/2005	NKV